

# AO4918



# **Asymmetric Dual N-Channel Enhancement Mode Field Effect Transistor**

# **General Description**

The AO4918 uses advanced trench technology to provide excellent R<sub>DS(ON)</sub> and low gate charge. The two MOSFETs make a compact and efficient switch and synchronous rectifier combination for use in DC-DC converters. A Schottky diode is co-packaged in parallel with the synchronous MOSFET to boost efficiency further Standard Product AO4918 is Pb-free (meets ROHS & Sony 259 specifications). AO4918L is a Green Product ordering option. AO4918 and AO4918L are electrically identical.

## **Features**

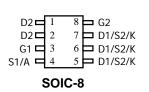
Q1

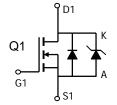
Q2

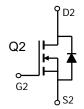
$$\begin{split} V_{DS}\left(V\right) &= 30V & V_{DS}(V) = 30V \\ I_{D} &= 9.3A \; (V_{GS} = 10V) & I_{D} = 8.3A \; \; (V_{GS} = 10V) \\ R_{DS(ON)} &< 14.5 m\Omega & <18 m\Omega \; \; \; \; (V_{GS} = 10V) \\ R_{DS(ON)} &< 16 m\Omega & <27 m\Omega \; \; \; \; (V_{GS} = 4.5V) \end{split}$$

#### **SCHOTTKY**

 $V_{DS}(V) = 30V, I_F = 3A, V_F < 0.5V@1A$ 







### Absolute Maximum Ratings T<sub>A</sub>=25°C unless otherwise noted

Parameter		Symbol	Max Q1	Max Q2	Units	
Drain-Source Voltage		$V_{DS}$	30	30	V	
Gate-Source Voltage		$V_{GS}$	±12	±20	V	
Continuous Drain	T <sub>A</sub> =25°C		9.3	8.3		
Current <sup>A</sup>	T <sub>A</sub> =70°C	I <sub>D</sub>	7.4	6.7	Α	
Pulsed Drain Current <sup>B</sup>		I <sub>DM</sub>	40	40		
	T <sub>A</sub> =25°C	P <sub>D</sub>	2	2	W	
Power Dissipation	T <sub>A</sub> =70°C	' D	1.28	1.28	VV	
Junction and Storage Temperature Range		$T_J$ , $T_{STG}$	-55 to 150	-55 to 150	°C	

Parameter Reverse Voltage		Symbol	Maximum Schottky	Units V	
		$V_{DS}$	30		
Continuous Forward	T <sub>A</sub> =25°C		3		
Current <sup>A</sup>	T <sub>A</sub> =70°C	I <sub>F</sub>	2.2	Α	
Pulsed Diode Forward Current <sup>B</sup>		I <sub>FM</sub>	20		
	T <sub>A</sub> =25°C	P <sub>D</sub>	2	W	
Power Dissipation <sup>A</sup>	ver Dissipation A T <sub>A</sub> =70°C		1.28	VV	
Junction and Storage	Temperature Range	$T_J$ , $T_{STG}$	-55 to 150	°C	

Parameter: Thermal Characteristics MOSFET Q1		Symbol	Тур	Max	Units	
Maximum Junction-to-Ambient A	t ≤ 10s	$ R_{\theta JA}$	53	62.5		
Maximum Junction-to-Ambient A	Steady-State	IV <sub>θ</sub> JA	81.9	110	°C/W	
Maximum Junction-to-Lead <sup>C</sup>	Steady-State	$R_{\theta JL}$	30.5	40		
					•	
Parameter: Thermal Characteristics MOSFET Q2		Symbol	Тур	Max	Units	
Maximum Junction-to-Ambient A	t ≤ 10s	$ R_{\theta JA}$	53	62.5		
Maximum Junction-to-Ambient A	Steady-State	IN <sub>θ</sub> JA	81.9	110	°C/W	
Maximum Junction-to-Lead <sup>C</sup>	Steady-State	$R_{ heta JL}$	30.5	40		

Thermal Characteristics Schottky							
Maximum Junction-to-Ambient <sup>A</sup> t ≤ 10s		D	50.4	62.5			
Maximum Junction-to-Ambient A	Steady-State	$R_{\theta JA}$	86	110	°C/W		
Maximum Junction-to-Lead <sup>C</sup>	Steady-State	$R_{\theta JL}$	26.6	40			

A: The value of R  $_{\theta JA}$  is measured with the device mounted on 1in  $^2$  FR-4 board with 2oz. Copper, in a still air environment with T  $_A$ =25°C. The value in any given application depends on the user's specific board design. The current rating is based on the t  $_{\perp}$  ≤ 10s thermal resistance rating.

- B: Repetitive rating, pulse width limited by junction temperature.
- C. The R  $_{\theta JA}$  is the sum of the thermal impedence from junction to lead R  $_{\theta JL}$  and lead to ambient.
- D. The static characteristics in Figures 1 to 6 are obtained using 80  $\mu s$  pulses, duty cycle 0.5% max.
- E. These tests are performed with the device mounted on 1 in <sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T <sub>A</sub>=25°C. The SOA curve provides a single pulse rating.
- F. The Schottky appears in parallel with the MOSFET body diode, even though it is a separate chip. Therefore, we provide the net forward drop, capacitance and recovery characteristics of the MOSFET and Schottky. However, the thermal resistance is specified for each chip separately.

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#### Q1 Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units
STATIC F	PARAMETERS						
$BV_{DSS}$	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$		30			V
	Zero Gate Voltage Drain Current.	V <sub>R</sub> =30V			0.007	0.05	
$I_{DSS}$	(Set by Schottky leakage)	$V_R = 30V, T_J = 125^{\circ}C$			3.2	10	mA
	(cot by conounty rountage)	$V_R = 30V, T_J = 150^{\circ}C$			12	20	
$I_{GSS}$	Gate-Body leakage current	$V_{DS}$ =0V, $V_{GS}$ = ±12V				100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS} I_{D}=250\mu A$		0.6	1.1	2	V
$I_{D(ON)}$	On state drain current	$V_{GS}$ =4.5V, $V_{DS}$ =5V		40			Α
		V <sub>GS</sub> =10V, I <sub>D</sub> =9.3A			11.7	14.5	mΩ
$R_{DS(ON)}$	Static Drain-Source On-Resistance	Т	<sub>J</sub> =125°C		15.4	19	11122
		$V_{GS}$ =4.5V, $I_{D}$ =8.8A			13.1	16	mΩ
<b>g</b> <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> =5V, I <sub>D</sub> =9.3A		30	37		S
$V_{SD}$	Diode+Schottky Forward Voltage	I <sub>S</sub> =1A			0.46	0.5	V
Is	Maximum Body-Diode+Schottky Continuous Current					3.5	Α
DYNAMIC	CPARAMETERS						
C <sub>iss</sub>	Input Capacitance				3740	4488	pF
Coss	Output Capacitance (FET + Schottky)	$V_{GS}$ =0V, $V_{DS}$ =15V, f=1MHz $V_{GS}$ =0V, $V_{DS}$ =0V, f=1MHz			295		pF
C <sub>rss</sub>	Reverse Transfer Capacitance				186		pF
$R_g$	Gate resistance				0.86	1.1	Ω
SWITCHI	NG PARAMETERS						
$Q_g$	Total Gate Charge				30.5	37	nC
$Q_{gs}$	Gate Source Charge	$V_{GS}$ =4.5V, $V_{DS}$ =15V, $I_{D}$ =	9.3A		4.5		nC
$Q_{gd}$	Gate Drain Charge				8.5		nC
t <sub>D(on)</sub>	Turn-On DelayTime				6	9	ns
t <sub>r</sub>	Turn-On Rise Time	$V_{GS}$ =10V, $V_{DS}$ =15V, $R_{L}$ =	1.6Ω,		8.2	12	ns
t <sub>D(off)</sub>	Turn-Off DelayTime	$R_{GEN}$ =3 $\Omega$			54.5	75	ns
$t_f$	Turn-Off Fall Time		Ī		10.5	15	ns
t <sub>rr</sub>	Body Diode + Schottky Reverse Recovery Time	I <sub>F</sub> =9.3A, dI/dt=100A/μs			23.5	28	ns
Q <sub>rr</sub>	Body Diode + Schottky Reverse Recovery Charge	I <sub>F</sub> =9.3A, dI/dt=100A/μs			13.3	16	nC

A: The value of R  $_{0.JA}$  is measured with the device mounted on 1 in  $^2$  FR-4 board with 2oz. Copper, in a still air environment with T  $_A$  =25°C. The value in any given application depends on the user's specific board design. The current rating is based on the t  $_{\sim}$  ≤ 10s thermal resistance rating.

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B: Repetitive rating, pulse width limited by junction temperature.

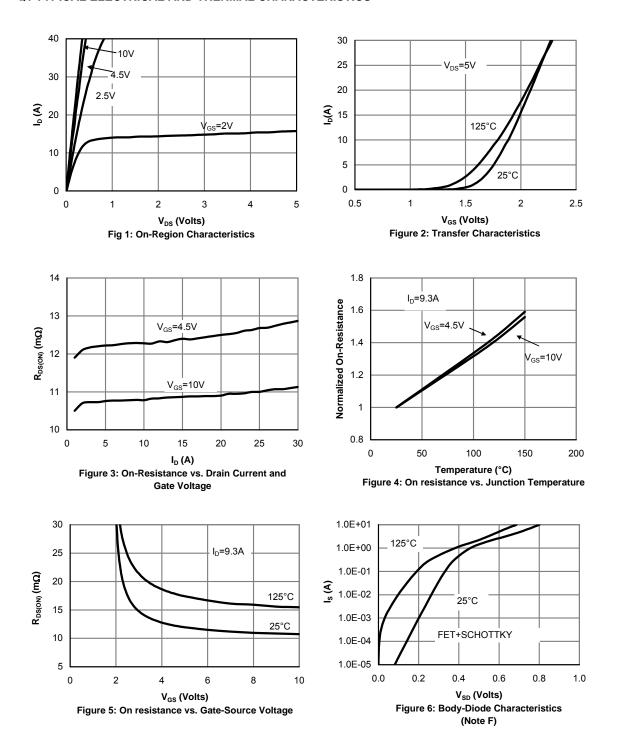
C. The R  $_{\theta JA}$  is the sum of the thermal impedence from junction to lead R  $_{\theta JL}$  and lead to ambient.

D. The static characteristics in Figures 1 to 6,12,14 are obtained using 80  $\mu s$  pulses, duty cycle 0.5% max.

E. These tests are performed with the device mounted on 1 in  $^2$  FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C. The SOA curve provides a single pulse rating.

F. The Schottky appears in parallel with the MOSFET body diode, even though it is a separate chip. Therefore, we provide the net forward drop, capacitance and recovery characteristics of the MOSFET and Schottky. However, the thermal resistance is specified for each chip separately Rev4: August 2005.

#### Q1 TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



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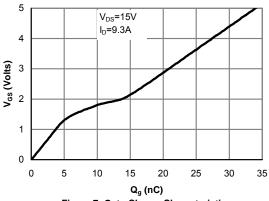


Figure 7: Gate-Charge Characteristics

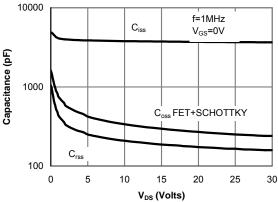


Figure 8: Capacitance Characteristics

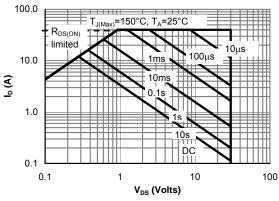


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

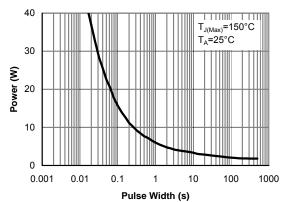


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

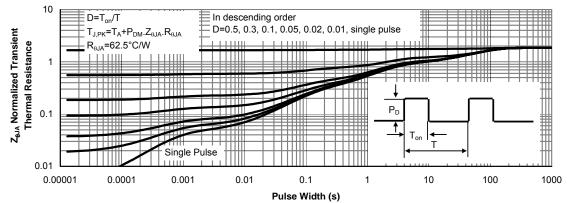


Figure 11: Normalized Maximum Transient Thermal Impedance

#### Q2 Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units	
STATIC PARAMETERS							
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	30			V	
lana	Zero Gate Voltage Drain Current	V <sub>DS</sub> =24V, V <sub>GS</sub> =0V		0.004	1		
I <sub>DSS</sub>	Zero Gate Voltage Drain Gurrent	T <sub>J</sub> =55°C	;		5	μА	
$I_{GSS}$	Gate-Body leakage current	$V_{DS}$ =0V, $V_{GS}$ = ±20V			100	nA	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$ $I_{D}=250\mu A$	1	1.8	3	V	
$I_{D(ON)}$	On state drain current	$V_{GS}$ =4.5V, $V_{DS}$ =5V	30			Α	
		V <sub>GS</sub> =10V, I <sub>D</sub> =8.3A		14.9	18	mΩ	
$R_{DS(ON)}$	Static Drain-Source On-Resistance	T <sub>J</sub> =125°C	;	22	27	1115.2	
		$V_{GS}$ =4.5V, $I_D$ =7A		21.6	27	mΩ	
g <sub>FS</sub>	Forward Transconductance	$V_{DS}$ =5V, $I_D$ =8.3A		23		S	
$V_{SD}$	Diode+Schottky Forward Voltage	I <sub>S</sub> =1A		0.45	0.5	V	
I <sub>S</sub>	Maximum Body-Diode+Schottky Continuous Current				3	Α	
DYNAMIC	PARAMETERS						
C <sub>iss</sub>	Input Capacitance	$V_{GS}$ =0V, $V_{DS}$ =15V, f=1MHz $V_{GS}$ =0V, $V_{DS}$ =0V, f=1MHz		1040	1250	pF	
C <sub>oss</sub>	Output Capacitance			180		pF	
$C_{rss}$	Reverse Transfer Capacitance			110		pF	
$R_g$	Gate resistance			0.7	0.85	Ω	
SWITCHI	NG PARAMETERS						
Q <sub>g</sub> (10V)	Total Gate Charge			19.2	24	nC	
$\overline{Q_g}$	Total Gate Charge	V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, I <sub>D</sub> =8.3A		9.36	12	nC	
$Q_{gs}$	Gate Source Charge	V <sub>GS</sub> -10V, V <sub>DS</sub> -13V, I <sub>D</sub> -0.3A		2.6		nC	
$Q_{gd}$	Gate Drain Charge	1		4.2		nC	
t <sub>D(on)</sub>	Turn-On DelayTime			5.2	7.5	ns	
t <sub>r</sub>	Turn-On Rise Time	$V_{GS}$ =10V, $V_{DS}$ =15V, $R_{L}$ =1.8 $\Omega$ ,		4.4	6.5	ns	
$t_{D(off)}$	Turn-Off DelayTime	$R_{GEN}$ =3 $\Omega$		17.3	25	ns	
t <sub>f</sub>	Turn-Off Fall Time	]		3.3	5	ns	
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I <sub>F</sub> =8.5A, dI/dt=100A/μs		16.7	21	ns	
Q <sub>rr</sub>	Body Diode Reverse Recovery Charge	I <sub>F</sub> =8.5A, dI/dt=100A/μs		6.7	10	nC	

A: The value of  $R_{\theta JA}$  is measured with the device mounted on  $1\text{in}^2$  FR-4 board with 2oz. Copper, in a still air environment with  $T_A$  =25°C. The value in any given application depends on the user's specific board design. The current rating is based on the t≤ 10s thermal resistance rating.

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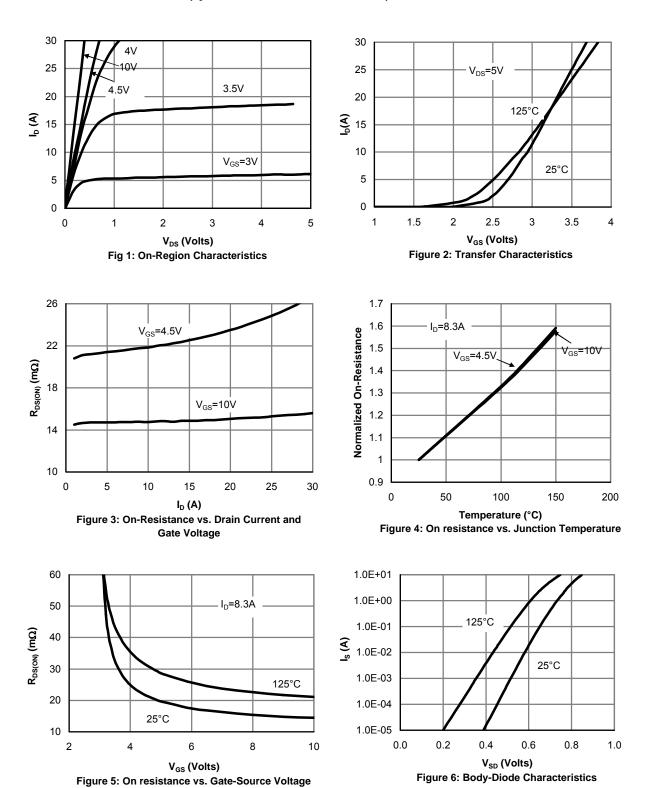
B: Repetitive rating, pulse width limited by junction temperature.

C. The R  $_{\theta JA}$  is the sum of the thermal impedence from junction to lead R  $_{\theta JL}$  and lead to ambient.

D. The static characteristics in Figures 1 to 6,12,14 are obtained using  $80\mu s$  pulses, duty cycle 0.5% max.

E. These tests are performed with the device mounted on 1 in  $^2$  FR-4 board with 2oz. Copper, in a still air environment with  $T_A$ =25°C. The SOA curve provides a single pulse rating.

## Q2 Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)



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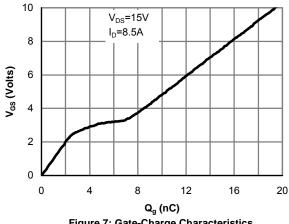


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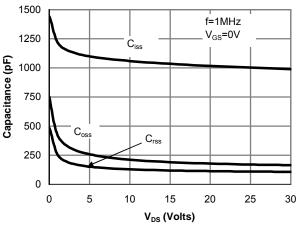


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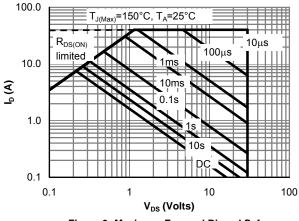


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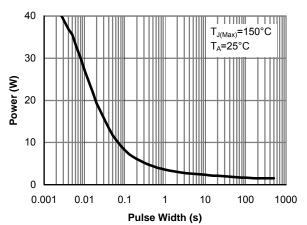


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

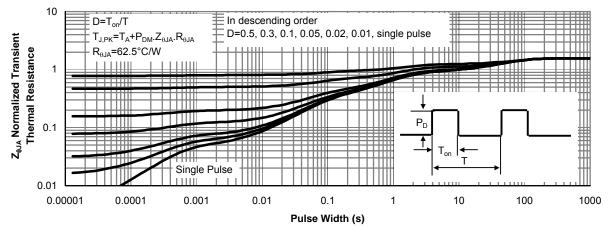


Figure 11: Normalized Maximum Transient Thermal Impedance



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